# MOSFET - N-Channel, SUPERFET® II

600 V, 52 A, 72 m $\Omega$ 

# **FCH072N60**

## **Description**

SUPERFET II MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, SUPERFET II MOSFET is suitable for various AC/DC power conversion for system miniaturization and higher efficiency.

### **Features**

- Typ.  $R_{DS(on)} = 66 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 95 nC)
- Low Effective Output Capacitance (Typ. Coss(eff.) = 421 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

### **Applications**

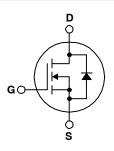
- Telecom / Sever Power Supplies
- Industrial Power Supplies



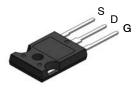
# ON Semiconductor®

### www.onsemi.com

V <sub>DS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
600 V	72 mΩ @ 10 V	52 A



**N-CHANNEL MOSFET** 



TO-247-3LD CASE 340CK

### **MARKING DIAGRAM**



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code

&K = Lot Code

FCH072N60 = Specific Device Code

### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

# **ABSOLUTE MAXIMUM RATINGS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter		FCH072N60	Unit
$V_{DSS}$	Drain to Source Voltage		600	V
V <sub>GSS</sub>	Gate to Source Voltage	- DC	±20	V
		- AC (f > 1 Hz)	±30	
I <sub>D</sub>	Drain Current:	– Continuous (T <sub>C</sub> = 25°C)	52	Α
		- Continuous (T <sub>C</sub> = 100°C)	33	
I <sub>DM</sub>	Drain Current:	- Pulsed (Note 1)	156	Α
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		1128	mJ
I <sub>AR</sub>	Avalanche Current (Note 1)		9.5	Α
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		4.8	mJ
dv/dt	MOSFET dv/dt Peak Diode Recovery dv/dt (Note 3)		100	V/ns
			20	
$P_{D}$	Power Dissipation	(T <sub>C</sub> = 25°C)	481	W
		- Derate Above 25°C	3.85	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to + 150	°C
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 seconds		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Repetitive rating: pulse–width limited by maximum junction temperature. 
  2.  $I_{AS}=9.5$  A,  $R_{G}=25$   $\Omega$ , Starting  $T_{J}=25$  °C. 
  3.  $I_{SD}\leq 26$  A, di/dt  $\leq 200$  A/ $\mu$ s,  $V_{DD}\leq 380$  V, Starting  $T_{J}=25$  °C.

### PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity
FCH072N60	FCH072N60	TO-247	Tube	N/A	N/A	30 Units

### THERMAL CHARACTERISTICS

Symbol	Parameter	FCH072N60	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	0.26	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient, Max.	40	

# **ELECTRICAL CHARACTERISTICS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Unit
OFF CHARA	ACTERISTICS					
BV <sub>DSS</sub> [	Drain to Source Breakdown Voltage	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 25°C	600	_	_	V
		I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150°C	650	_	_	
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 10 mA, Referenced to 25°C	-	0.67	-	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	_	_	1	μΑ
		$V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}, T_{C} = 125 ^{\circ}\text{C}$	_	4.1	_	
I <sub>GSS</sub>	Gate to Body Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	_	<b>1</b> –	±100	nA
ON CHARA	CTERISTICS		•		-	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.5	_	3.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 26 A	_	66	72	mΩ
9FS	Forward Transconductance	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 26 A	_	48	_	S
OYNAMIC C	HARACTERISTICS			•		
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 380 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	4430	5890	pF
C <sub>oss</sub>	Output Capacitance	1 1	_	115	155	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		_	4.43	_	pF
C <sub>oss(eff.)</sub>	Effective Output Capacitance	V <sub>DS</sub> = 0 V to 480 V, V <sub>GS</sub> = 0 V	_	421	_	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10 V	V <sub>DS</sub> = 380 V, I <sub>D</sub> = 26 A, V <sub>GS</sub> = 10 V	_	95	125	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	(Note 4)	_	21	_	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge		_	24	_	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	0.93	-	Ω
SWITCHING	CHARACTERISTICS			•		
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 380 V, I <sub>D</sub> = 26 A,	-	33	76	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 10 \text{ V, R}_{g} = 4.7 \Omega$ (Note 4)	_	23	56	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	(1000 4)	_	97	204	ns
t <sub>f</sub>	Turn-Off Fall Time		_	3.5	17	ns
DRAIN-SOU	RCE DIODE CHARACTERISTICS		•	•		
I <sub>S</sub>	Maximum Continuous Source to Drain Diode Forward Current		_	_	52	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		_	_	156	Α
V <sub>SD</sub>	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 26 A	_	_	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 26 A,	_	495	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>F</sub> /dt = 100 A/μs	_	13	_	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature.

### **TYPICAL CHARACTERISTICS**

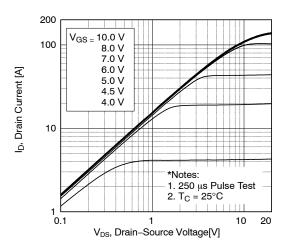


Figure 1. On-Region Characteristics

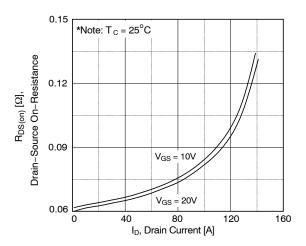


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

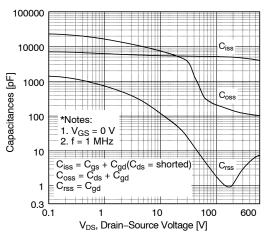


Figure 5. Capacitance Characteristics

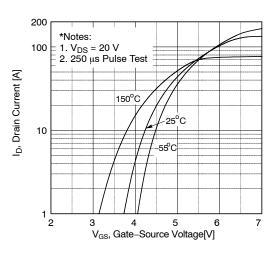


Figure 2. Transfer Characteristics

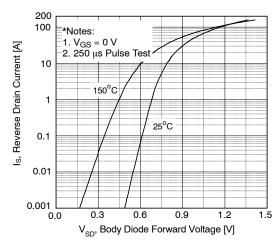


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

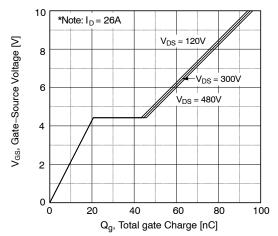


Figure 6. Gate Charge Characteristics

## **TYPICAL CHARACTERISTICS**

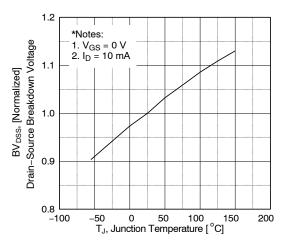


Figure 7. Breakdown Voltage Variation vs. Temperature

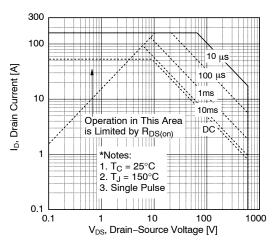


Figure 9. Maximum Safe Operating Area

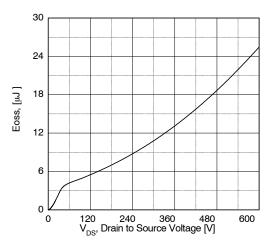


Figure 11. Eoss vs. Drain to Source Voltage

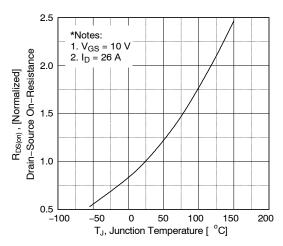


Figure 8. On–Resistance Variation vs. Temperature

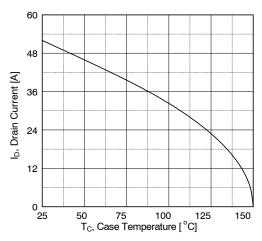


Figure 10. Maximum Drain Current vs. Case Temperature

# **TYPICAL CHARACTERISTICS**

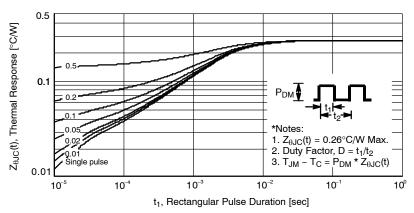


Figure 12. Transient Thermal Response Curve

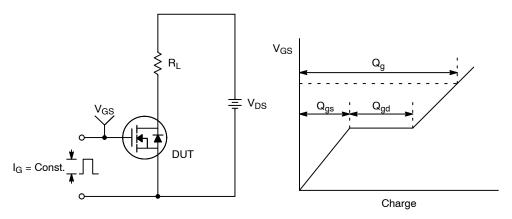


Figure 13. Gate Charge Test Circuit & Waveform

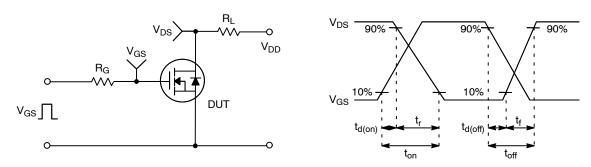


Figure 14. Resistive Switching Test Circuit & Waveforms

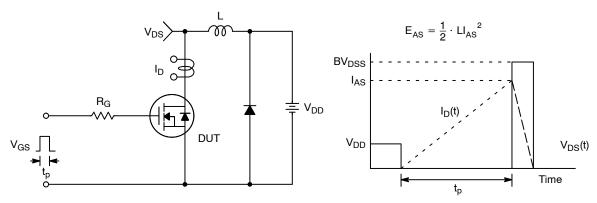


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

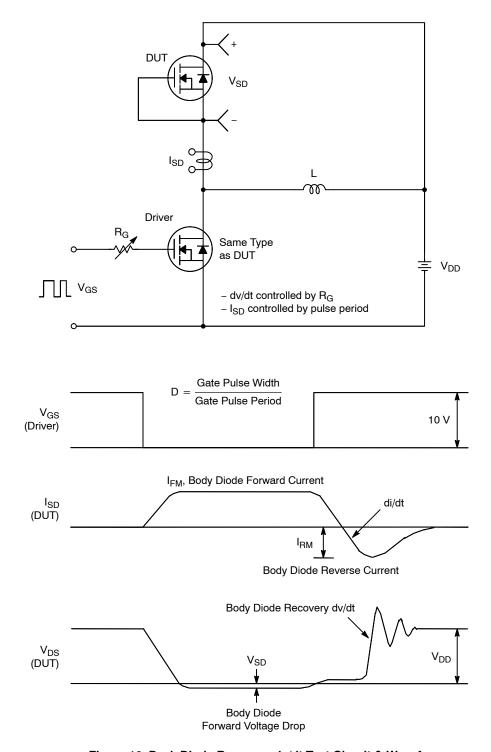
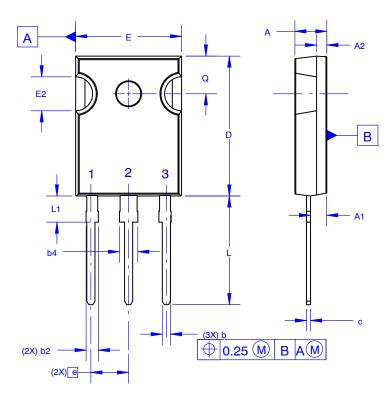


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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## TO-247-3LD SHORT LEAD

CASE 340CK ISSUE A



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code

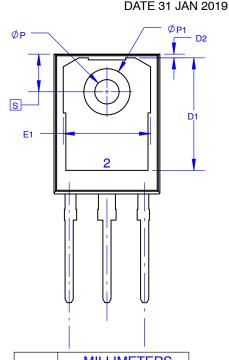
A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



DIM	MILLIMETERS				
DIIVI	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
A1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D	20.32	20.57	20.82		
D1	13.08	~	~		
D2	0.51	0.93	1.35		
E	15.37	15.62	15.87		
E1	12.81	~	~		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	15.75	16.00	16.25		
L1	3.69	3.81	3.93		
ØΡ	3.51	3.58	3.65		
Ø <b>P1</b>	6.60	6.80	7.00		
Q	5.34	5.46	5.58		
S	5.34	5.46	5.58		

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DESCRIPTION:	TO-247-3LD SHORT LEAD		PAGE 1 OF 1	

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